Electronic Supplementary Material (ESI) for Journal of Materials Chemistry C. This journal is © The Royal Society of Chemistry 2020

### A N-H functionalized perylene diimide with strong red-light absorption for green solvent processed organic electronics

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### TABLE OF CONTENTS

| 2. Synthetic Procedures43. NMR Spectra64. Mass Spectra95. Elemental Analysis106. Thermal Analysis117. SC-XRD138. Electrochemical Analysis149. Optical Analysis1610. Photos2011. Example OFET Plots2112. References22 | 1. Materials and Methods    | 2 |
|--|-----------------------------|---|
| 3. NMR Spectra64. Mass Spectra95. Elemental Analysis106. Thermal Analysis117. SC-XRD138. Electrochemical Analysis149. Optical Analysis1610. Photos2011. Example OFET Plots2112. References22                         | 2. Synthetic Procedures     |   |
| 4. Mass Spectra95. Elemental Analysis106. Thermal Analysis117. SC-XRD138. Electrochemical Analysis149. Optical Analysis1610. Photos2011. Example OFET Plots2112. References22  | 3. NMR Spectra              | 6 |
| 5. Elemental Analysis106. Thermal Analysis117. SC-XRD138. Electrochemical Analysis149. Optical Analysis1610. Photos2011. Example OFET Plots2112. References22  | 4. Mass Spectra             | 9 |
| 6. Thermal Analysis117. SC-XRD138. Electrochemical Analysis149. Optical Analysis1610. Photos2011. Example OFET Plots2112. References22   | 5. Elemental Analysis       |   |
| 7. SC-XRD138. Electrochemical Analysis149. Optical Analysis1610. Photos2011. Example OFET Plots2112. References22  | 6. Thermal Analysis         |   |
| <ul> <li>8. Electrochemical Analysis</li></ul>   | 7. SC-XRD                   |   |
| 9. Optical Analysis1610. Photos2011. Example OFET Plots2112. References22  | 8. Electrochemical Analysis |   |
| 10. Photos   | 9. Optical Analysis         |   |
| 11. Example OFET Plots    21      12. References    22   | 10. Photos                  |   |
| 12. References   | 11. Example OFET Plots      |   |
|  | 12. References              |   |

## **1. Materials and Methods**

**Materials:** All reagents and solvents were purchased from Millipore-Sigma and used without further purification.

**Nuclear Magnetic Resonance (NMR):** <sup>1</sup>H and <sup>13</sup>C NMR spectroscopy experiments were recorded using a Bruker Avance III 500 MHz spectrometer. All experiments were performed in chloroform-d (CDCl<sub>3</sub>). Chemical shifts (referenced to residual solvent) were reported in parts per million (ppm). Multiplicities were reported as follows: singlet (s), doublet of doublets (dd), and multiplets (m).

**High-resolution Mass Spectrometry (HRMS):** High-resolution MALDI mass spectrometry measurements were performed courtesy of Johnson Li in the Chemical Instrumentation Facility at the University of Calgary. A Bruker Autoflex III Smartbeam MALDI-TOF (Na:YAG laser, 355 nm), setting in positive reflective mode, was used to acquire spectra.

**CHN Elemental Analysis**: Elemental analyses were performed by Johnson Li in the Chemical Instrumentation Facility at the University of Calgary (UofC). A Perkin Elmer 2400 Series II CHN Elemental Analyzer was used to obtain CHN data, using ~1.5 mg of sample (with particle sizes ranging between 0.2 and 0.5 mm in diameter).

**UV-Visible Spectroscopy (UV-Vis):** All optical absorption measurements were recorded using Agilent Technologies Cary 60 UV-Vis spectrometer at room temperature. All solution UV-Vis experiments were run using 2 mm quartz cuvettes. Stock solutions (1.0 mg/mL) of each compound were prepared in CHCl<sub>3</sub>, serially diluted to concentrations between  $10^{-5} - 10^{-6}$  M, and then used to construct calibration curves for determining molar absorptivity. Neat films were prepared from CHCl<sub>3</sub> solutions by spin-coating from a 1 % wt/v solution onto clean Corning glass micro slides. Alcohol processed thin films were cast from 40 µL of a 5 mg/mL solution of **X1** in 1:1 *n*-propanol:*n*-butylamine. Alcohol processed solution optical absorbance measurements were recorded for  $10^{-5}$  M solutions of **X1** in 1:1 *n*-propanol:*n*-butylamine. Prior to use, glass slides were cleaned with acetone and isopropanol, followed by UV/ozone treatment using a Novascan UV/ozone cleaning system.

**Cyclic Voltammetry (CV):** Electrochemical measurements were performed using a CH Instruments Inc. Model 1200B Series Handheld Potentiostat. A standard 3-electrode setup was utilized, consisting of a freshly polished glassy carbon disk working electrode (WE), Pt-wire counter electrode (CE), and Ag-wire pseudo-reference electrode (RE). All measurements were referenced to ferrocene (Fc+/0) as internal standard. All cyclic voltammetry experiments were performed at a scan rate of 100 mV/s. Sample solutions, with 1 mM compound and 0.1 M tetrabutylammonium hexafluorophosphate (TBAPF<sub>6</sub>) supporting electrolyte, were prepared in anhydrous dichloromethane. All electrochemical solutions were sparged with dry gas (either N<sub>2</sub> or argon) for 5 minutes to deoxygenate the system prior to measurements.

**Single Crystal XRD:** Single crystals of  $C_{55}H_{49}N_3O_4$ , **X1**, were grown from *o*-xylene (1 mL) and hexanes (1 mL) at 298K. A suitable crystal was selected and mounted on a glass loop

using Paratone oil. Diffraction experiments were performed on a Bruker Smart diffractometer equipped with an Incoatec Microfocus (Cu K $\alpha$ ,  $\lambda = 1.54178$  Å) and an APEX II CCD detector. The crystal was kept at 173 K during data collection. Diffractions spots were integrated and scaled with SAINT <sup>3</sup> and the space group was determined with XPREP<sup>4</sup>. Using Olex2<sup>5</sup>, the structure was solved with the ShelXT<sup>6</sup> structure solution program using Intrinsic Phasing and refined with the ShelXL<sup>7</sup> refinement package using Least Squares minimisation.

#### **Organic Field Effect Transistors**

#### Fabrication:

Si/SiO<sub>2</sub> substrates with patterned Au contacts (bottom-gate bottom-contact) were purchased from Fraunhofer IPMS, having channel lengths from 2.5 to 20  $\mu$ m, channel width of 2000  $\mu$ m and dielectric thickness of 230 nm. The substrates were plasma treated for 10 minutes, then surface-functionalized with octyltrichlorosilane (1% v/v in toluene) for one hour. X1 was dissolved in 1:1 isopropanol/n-butylamine or n-propanol/n-butylamine solutions at 5 mg/mL. These solutions were then spin-coated at 1000 rpm for 60 seconds onto the treated substrates in an inert atmosphere.

#### Characterization:

Devices were characterized under vacuum ( < 0.1 Pa) in a custom oesProbe A10000-P290 system (Element Instrumentation Inc. & Kreus Design Inc.). A Keithley 2614B was used to modulate the gate-source voltage (V<sub>GS</sub>) and source-drain voltage (V<sub>DS</sub>) and measure the source-drain current (I<sub>DS</sub>). A constant V<sub>DS</sub> of 70 V was used to obtain the saturation field-effect electron mobility and threshold voltage over a V<sub>GS</sub> range of 0 to 100 V.

Calculation of Electron Mobility:

The relationship between  $I_{DS}$  and  $V_{GS}$  in the saturation region are given in **Equation 1**:

(1) 
$$I_{DS} = \frac{\mu C_i W}{2L} (V_{GS} - V_T)^2$$

Where  $C_i$  is the capacitance of the gate dielectric (1.5 x 10<sup>-4</sup> F m<sup>-2</sup>),  $\mu$  is the field-effect electron mobility of the material,  $V_T$  is the threshold voltage, W is the width of the channel, and L is the length of the channel.

To find the mobility, the equation can be rearranged by taking the square root, giving **Equation 2**:

(2) 
$$\sqrt{I_{DS}} = \sqrt{\frac{\mu C_i W}{2L}} (V_{GS} - V_T)$$

This gives a linear relationship between  $\sqrt{I_{DS}}$  and V<sub>GS</sub>. The slope of linear region of the  $\sqrt{I_{DS}}$  vs V<sub>GS</sub> curve gives  $\sqrt{\frac{\mu C_i W}{2L}}$ , which all constants are known except  $\mu$ , for which we can solve. V<sub>T</sub> is simply the x-intercept of this line.

### 2. Synthetic Procedures



PDI-NO<sub>2</sub> (2.4 g, 4.2 mmol, 1 eq) and anhydrous SnCl<sub>2</sub> (8 grams, 42 mmol, 10 eq) were added to a 125 mL round bottom flask (excess of SnCl<sub>2</sub> was shown to improve the yield when compared to similar literature reaction<sup>1</sup>). 50 mL of THF was added, followed by 3 mL of H<sub>2</sub>O (H<sub>2</sub>O is needed in order to drive the equilibrium towards **1**). The flask was equipped with a reflux condenser and the reaction was refluxed. The reaction mixture changed from red to blue when heating commenced. After TLC indicated the reaction was complete, the solvent was removed *in vacuo*, the product was slurried in H<sub>2</sub>O and poured into a 500 L beaker. 300 mL of H<sub>2</sub>O was added to the beaker and it was stirred overnight to dissolve Sn-based residues. The resulting H<sub>2</sub>O slurry was vacuum filtered to isolate the blue solid. The solid was washed with an additional 2 L of H<sub>2</sub>O to ensure Sn-based residues were removed. Compound **1** (PDI-NH<sub>2</sub>) was obtained in 53% yield (0.76 g, 0.14 mmol). <sup>1</sup>H-NMR data matches the literature for this compound.<sup>2</sup>



Benzophenone (29 mg, 0.16 mmol, 1.6 eq.) was added to a 10 mL pressure tube equipped with a stir bar. *o*-Xylene (2 mL) was added, followed by trifluoromethanesulfonic acid (7.8  $\mu$ L, 0.09 mmol, 0.9 eq.), and the mixture was stirred for 5 minutes. Compound **1** (54 mg, 0.10 mmol, 1.0 eq.) was added, the vial was sealed, and the reaction was heated at 165 °C for 24 hrs. During the reaction the solution changed from a dark red colour to dark green. The reaction mixture was poured into a 250 mL separatory funnel and diluted with 35 mL of ethyl acetate. The organic layer was washed twice with saturated NaHCO<sub>3</sub>(aq) to neutralize residual acid and once with brine. The organic layer was collected, dried with anhydrous MgSO<sub>4</sub>, and gravity filtered into a 250 mL round bottom flask. The solvent was removed *in vacuo* and the resulting crude solid was dissolved in 30 mL of dichloromethane and passed through a Silica plug eluting with dichloromethane to separate the product from excess benzophenone. The green band was collected, and the solvent was removed *in vacuo*. The resulting dark green solid was precipitated with a 1:3 MeOH:H<sub>2</sub>O solution (the product was found to be partially soluble in 100% MeOH) and collected via vacuum filtration. Compound **X1** was obtained in 84% yield (59 mg, 0.084 mmol).

<sup>1</sup>H NMR (500 MHz, CDCl<sub>3</sub>, 27 °C): δ 8.55 (m, 1H, Ha), 8.57 (dd, J = 8.0 Hz, 2H, Hb), 8.41 (m, 1H, Hc), 8.09 (m, J = 8.3 Hz, 1H, Hd), 7.37 (m, J, 8H, He), 7.32 (m, 2H, Hf), 5.69 (s, 1H, Hg), 5.01 (s, 1H, Hh), 2.22 (m, 4H, Hi), 1.90 (m, 4H, Hj), 0.89 (m, 12H, Hk).

<sup>13</sup>C NMR (151 MHz, CDCl<sub>3</sub>, 27 °C): δ 144.83 (Q), 140.82 (Q), 135.42 (Q), 131.57 (Q), 130.46 (Q), 128.68 (ar-CH), 128.33 (Q), 127.96 (Ph), 127.95 (Ph), 127.58 (ar-CH), 125.61 (Q), 124.62 (ar-CH), 123.18 (Q), 122.90 (ar-CH), 121.34 (ar-CH), 112.57 (Q), 67.92 (Q), 57.06 (CH), 56.96 (CH), 24.47 (CH<sub>2</sub>), 24.44, (CH<sub>2</sub>), 10.87 (CH<sub>3</sub>), 10.73 (CH<sub>3</sub>).

HRMS ([M-2H]+H<sup>+</sup>) calculated for C<sub>47</sub>H<sub>38</sub>N<sub>3</sub>O<sub>4</sub>: 708.2857; detected [M-2H]+H<sup>+</sup>: 708.2861

UV-Vis λ (M<sup>-1</sup> cm<sup>-1</sup>): 433 nm (18629), 651 nm (28469)

CHN theoretical (%) C: 79.53, H: 5.54, N: 5.92; found (%) C: 78.83; H: 5.75; N: 5.92

## 3. NMR Spectra



Figure S1: <sup>1</sup>H-NMR spectrum of X1 (500 MHz, CDCl<sub>3</sub>).



=

quaternary carbons do not appear in the spectrum or have resonances with very low resolution.



# 4. Mass Spectra



Figure S4: HR-MALDI-TOF-MS Spectrum of X1.

# **5. Elemental Analysis**

| Department of Chemistry |         | EA Da | te:            | 1/8/202 | :0    |      |
|-------------------------|---------|-------|----------------|---------|-------|------|
| Name:                   | DYLAN   |       | Group:         | GW      |       |      |
| Sample:                 | X1-95-1 |       | Weight (mg):   |         | 1.098 |      |
| %C (Actual):            |         | 78.83 | %C (Theorectio | al):    | 7     | 9.53 |
| %H (Actual):            |         | 5.75  | %H (Theoretica | al):    |       | 5.54 |
| %N (Actual):            |         | 5.92  | %N (Theoretica | al):    |       | 5.92 |

Comments:

Figure S5: CHN elemental analysis data sheet for X1.

# 6. Thermal Analysis



Figure S6: Thermogravimetric Analysis of X1.



Figure S7: Differential Scanning Calorimetry of X1.

## 7. SC-XRD

| 5   |  |
|---|--|
| Identification code                         | X1   |
| Empirical formula                           | C55H49N3O4   |
| Formula weight                              | 815.97   |
| Temperature/K                               | 173.0  |
| Crystal system                              | monoclinic   |
| Space group                                 | P21/n  |
| a/Å   | 14.2115(4)   |
| b/Å   | 21.6669(5)   |
| c/Å   | 14.3552(3)   |
| α/°   | 90   |
| β/°   | 104.079(2)   |
| γ/°   | 90   |
| Volume/Å <sup>3</sup>                       | 4287.46(18)  |
| Z   | 4  |
| $\rho_{calc}g/cm^3$                         | 1.264  |
| $\mu/mm^{-1}$                               | 0.626  |
| F(000)                                      | 1728.0   |
| Crystal size/mm <sup>3</sup>                | $0.306\times0.157\times0.071$                          |
| Radiation                                   | $CuK\alpha (\lambda = 1.54178)$                        |
| $2\Theta$ range for data collection/°       | 7.546 to 130.29  |
| Index ranges                                | $-16 \le h \le 16, -25 \le k \le 25, -15 \le l \le 16$ |
| Reflections collected                       | 26955  |
| Independent reflections                     | 7146 [ $R_{int} = 0.0234$ , $R_{sigma} = 0.0203$ ]     |
| Data/restraints/parameters                  | 7146/419/658   |
| Goodness-of-fit on F <sup>2</sup>           | 1.034  |
| Final R indexes [I>= $2\sigma$ (I)]         | $R_1 = 0.0485, wR_2 = 0.1374$                          |
| Final R indexes [all data]                  | $R_1 = 0.0570, wR_2 = 0.1462$                          |
| Largest diff. peak/hole / e Å <sup>-3</sup> | 0.81/-0.28   |

Table S1: Crystal data and structure refinement for X1

## 8. Electrochemical Analysis

| Ox Eon (V) <sup>a</sup> | Ox E <sub>1/2</sub> (V) <sup>b</sup> | Red Eon (V) <sup>c</sup> | <b>Red E</b> <sub>1/2</sub> (V) <sup>d</sup> | IP (eV) <sup>e</sup> | EA (eV) <sup>e</sup> | Eg (eV) |
|-------------------------|--------------------------------------|--------------------------|--|----------------------|----------------------|---------|
| 0.5 V                   | 0.62                                 | -1.1                     | -1.22, -1.43                                 | 5.4                  | 3.6                  | 1.8     |

<sup>a</sup> Onset of oxidation

<sup>b</sup> Oxidation half potential

<sup>c</sup> Reduction onset

<sup>d</sup> Reduction half potential

<sup>e</sup> Energy values were calculated by ( $E_{1/2}$  + 4.8 eV) where Fc HOMO = 4.8 eV.<sup>8</sup>



Figure S8: Differential Pulse Voltammogram of X1 ( $\approx$ 1 mM) in CH<sub>2</sub>Cl<sub>2</sub>, recorded at 100 mV/s.



**Figure S9:** Cyclic Voltammogram of **X1** (green,  $\approx 1$  mM), **1** (blue,  $\approx 1$  mM), and **PDI** (red,  $\approx 1$  mM), in CH<sub>2</sub>Cl<sub>2</sub>, recorded at 100 mV/s. Half potentials listed. Fc/Fc<sup>+</sup> couple shown (0V, internal standard)



## 9. Optical Analysis



**Figure S10:** (TOP) Solution optical absorption spectrum of **X1** in CHCl<sub>3</sub>, with calibration curve inset. (BOTTOM) Comparison of solution (CHCl<sub>3</sub>) and film (spin-cast from CHCl<sub>3</sub>) spectra of **X1**.



Figure S11: Photoluminescence emission spectra for X1 in CHCl<sub>3</sub> solution.



Figure S12: Comparison of the optical absorption spectra of X1 (green), 1 (blue), and PDI (red) in CHCl<sub>3</sub>.





**Figure S13:** Comparison of the optical absorption spectra of **X1** (green) and **1** (blue). Solutions were diluted from 5 mg/mL in *n*-propanol / butylamine (1:1 v/v) stock solutions. Films were spin-cast from 5 mg/mL in *n*-propanol / butylamine (1:1 v/v) stock solutions. Note: compound **1** = PDI-NH<sub>2</sub>. Solid lines (solution spectra) and dashed lines (film spectra).



## **10. Photos**



**Figure S14:** Pictures of 5 mg/mL solutions of: **PDI** (1) *n*-propanol and (2) *n*-propanol / butylamine (1/1 v/v). **1** (3) *n*-propanol and (4) *n*-propanol / butylamine (1:1 v/v). **X1** (5) n-propanol and (6) *n*-propanol / butylamine (1/1 v/v). All compounds could not be fully dissolved (up to 5 mg/mL) in *n*-propanol alone as seen with the particles on the vial sides. Note: compound **1** = PDI-NH<sub>2</sub>.



**Figure S15:** Pictures of thin-films of **X1** spin-cast from 5 mg/mL solutions. (1) CHCl<sub>3</sub>; (2) 2-Methyl THF; (3) *o*-xylene (4) EtOAc; (5) *n*-PrOH / *n*-butylamine (1:1 v/v).



**Figure S16:** Example OFET output plots (a), transfer plots (b), and transfer plots showing linear region (c) for devices based on films of **X1** processed from *n*-propanol:*n*-butylamine (1:1) solutions and annealed at  $200^{\circ}$ C.

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